

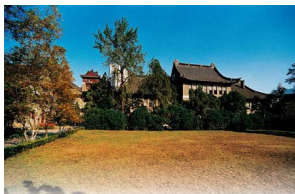
Top Pair Cross Section Measurement in the Semileptonic Channels in ATLAS

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Outline

- Introduction to $t\bar{t}$ cross section measurement with ATLAS
- Method of the cross section measurement in l+jets channels
- Recent work and progress
 - ▶ Trigger efficiency measurement using top events
 - ▶ BTagging efficiency measurement using top events



Part1. Introduction: $t\bar{t}$ cross section measurement

- In p-p collision, top pairs are produced through gluon-gluon and quark-antiquark scattering

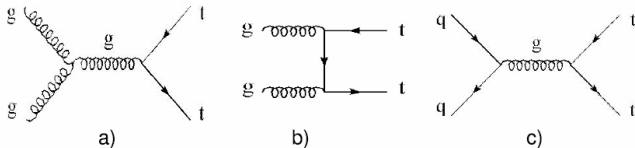


Figure: Lowest order: gluon-gluon scattering (a) & (b), quark-quark scattering (c)

- $t \rightarrow Wb$ is close to 100%, $W \rightarrow l + \nu \sim \frac{1}{3}$ and $W \rightarrow q\bar{q} \sim \frac{2}{3}$



Top pair branching fraction

Top Pair Decay Channels

$c\bar{s}$	electron+jets	muon+jets	tau+jets	all-hadronic					
$u\bar{d}$									
$\tau^-\tau^+$	e^+e^-	$\mu^+\mu^-$	$\tau^+\tau^-$				tau+jets		
$\mu^-\mu^+$	$e^+\mu^-$	$e^-\mu^+$	$\mu^+\mu^-$				muon+jets		
e^-e^+	e^+e^-	$e^+\mu^-$	$e^-\mu^+$	electron+jets					
W decay	e^+	μ^+	τ^+	$u\bar{d}$	$c\bar{s}$				

expect	7 TeV	10 TeV	14 TeV
$\sigma_{t\bar{t}}$ (pb)	160.79	402.53	886.28

- chance to measure $t\bar{t}$ cross section at different energies

Semi-leptonic channels $\sim \frac{4}{9}$

Di - leptonic channels $\sim \frac{1}{9}$

Full-hadronic channels $\sim \frac{4}{9}$

- semi-leptonic: high branching ratio
 \Rightarrow best precision
- di-leptonic: very clean, low background
 \Rightarrow used as a tool

\Leftarrow Assuming top mass 172.5 GeV,
at NNLO precision



Tevatron results

- Tevatron Run II, 1fb^{-1} $p\bar{p}$ collision, $\sqrt{s} = 1.96$ TeV
- Theory: 6.8 ± 0.6 pb at NLO + threshold resummation, m_t at 175 GeV
- $7.3 \pm 0.5(\text{stat}) \pm 0.6(\text{sys}) \pm 0.4(\text{lum})$ pb for CDF
- $7.4 \pm 0.5(\text{stat}) \pm 0.6(\text{sys}) \pm 0.4(\text{lum})$ pb for D0

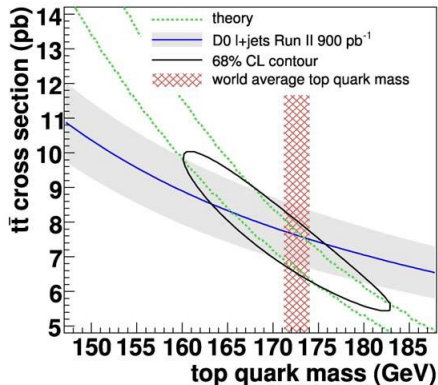


Figure : $t\bar{t}$ cross section changes in the function of top mass

\Rightarrow check for top mass measurement on ATLAS



Measuring $t\bar{t}$ cross section

- Counting method, determination of the cross section:

$$\sigma = \frac{N_{sig}}{\mathcal{L} \times \epsilon} = \frac{N_{obs} - N_{bkg}}{\mathcal{L} \times \epsilon}$$

- To do this, we need to understand:
 - ▶ The integrated luminosity of data
 - ▶ Acceptance of the detectors
 - ▶ Objects (electron, muon, jet) identification efficiency
 - ▶ **Trigger efficiency for electron and muon**
 - ▶ Event selection efficiency
 - ▶ **B jet tagging efficiency**
 - ▶ Level of backgrounds



Event selection

- Selection in $t\bar{t} \rightarrow e\nu b \mu\nu b, \mu\mu, ee$
 1. Exactly 2 isolated leptons $p_T > 20$ GeV (e or μ)
 2. Two leptons have opposite charge
 3. $|M_U - M_Z| > 5$ GeV ($\mu\mu, ee$ channels)
 4. $E_T^{\text{miss}} > 20$ GeV ($e\mu$), $E_T^{\text{miss}} > 35$ GeV ($\mu\mu, ee$)
 5. At least 2 jets with $p_T > 20$ GeV
- Selection in $t\bar{t} \rightarrow e\nu b qqb, t\bar{t} \rightarrow \mu\nu b qqb$
 1. Exactly 1 isolated lepton $p_T > 20$ GeV (e or μ)
 2. $E_T^{\text{miss}} > 20$ GeV
 3. At least 4 jets with $p_T > 20$ GeV
 4. At least 3 jets with $p_T > 40$ GeV



Part2. Trigger efficiency measurement

- Usually $Z \rightarrow e^+e^-$ and $Z \rightarrow \mu^+\mu^-$ are used, but it needs an interpretation into $t\bar{t}$ events
- We measure the trigger efficiencies (e10 and mu10) using top events
 - ▷ Efficiencies in $t\bar{t} \rightarrow e(\mu)\nu b qqb$ are to be estimated
 - ▷ Efficiencies in the dileptonic channels are the measured
 - ▷ Trigger efficiencies for identified isolated electrons or muons
- In $t\bar{t} \rightarrow e\nu b \mu\nu b$, mu10 (e10) trigger is passed \Rightarrow directly measure e10 (mu10) trigger efficiency \Rightarrow Triggered not only by leptons from top, but also possibly from b jets
- In $t\bar{t} \rightarrow e\nu b e\nu b$ and $t\bar{t} \rightarrow \mu\nu b \mu\nu b$, tag and probe method is used \Rightarrow Here we measure really the efficiency for one object
- 10 TeV, MC@NLO + Herwig, about 7.7 fb^{-1}



Trigger efficiency in $t\bar{t} \rightarrow e(\mu)\nu b qqb$

Channel	# Events(100 pb^{-1})	TrigEff_e10, mu10
$t\bar{t} \rightarrow e\nu b qqb$	594.3 ± 2.8	$99.8 \pm 0.1\%$
$t\bar{t} \rightarrow \mu\nu b qqb$	719.0 ± 3.1	$88.1 \pm 0.2\%$

Table: Electron and muon trigger efficiency in $t\bar{t} \rightarrow e(\mu)\nu b qqb$

- ▶ e10 trigger efficiency is very high \Leftarrow cut electron p_T at 20 GeV
- ▶ About 7.7 fb^{-1} $t\bar{t}$ events \Rightarrow statistical uncertainty
- ▶ mu10 trigger efficiency in $t\bar{t} \rightarrow e\nu b qqb$, $t\bar{t} \rightarrow e\nu b e\nu b \sim 10\%$
- ▶ e10 trigger efficiency in $t\bar{t} \rightarrow \mu\nu b qqb$, $t\bar{t} \rightarrow \mu\nu b \mu\nu b \sim 3\%$



mu10 efficiency with $e\mu$ method

Channel	# Evt (100 pb ⁻¹)	TrigEff_mu10
$t\bar{t} \rightarrow e\nu b \mu\nu b$	277.2±1.9	88.2±0.2%
$t\bar{t}$ other	41.0±0.8	88.3±2.0%
single top	11.2±0.9	93.6±2.0%
Z + jets	12.9±1.1	89.1±1.8%
W + jets	1.7±0.5	≥72.7% @68%cl
diboson	9.7±0.3	89.1±1.1%
total bkg	75.8±2.5	89.7±0.5%

Work in Progress !

- ▶ Other $t\bar{t}$ leptonic channels (eg. $t\bar{t} \rightarrow e\nu b \tau\nu b$) are taken as backgrounds here
- ▶ Backgrounds are not biasing the measurement



mu10 efficiency with $\mu\mu$ method

Channel	# Evt (100 pb^{-1})	TrigEff_mu10
$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	149.7 ± 1.4	$86.9 \pm 0.2\%$
$t\bar{t}$ other	24.3 ± 0.6	$87.8 \pm 0.7\%$
single top	6.3 ± 0.7	$86.6 \pm 2.7\%$
Z + jets	17.9 ± 1.1	$86.4 \pm 1.8\%$
W + jets	0.6 ± 0.2	$72.2 \pm 9.1\%$
diboson	5.3 ± 0.3	$85.8 \pm 1.2\%$
total bkg	54.4 ± 2.0	$86.9 \pm 0.6\%$

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- We expect $\epsilon(t\bar{t} \rightarrow \mu\nu b q\bar{q}b) = 86.9\% + (1-86.9\%) \times 10\% = 88.2\%$

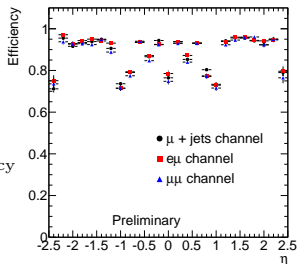
not selected μ
but trigger event

efficiency of mu10
from $t\bar{t} \rightarrow e\nu b q\bar{q}b$

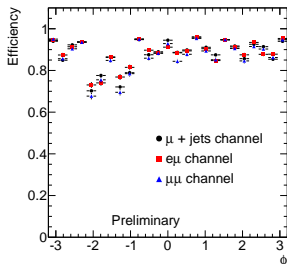


mu0 efficiency as a function of η , ϕ , p_T and nJet

- On the η plot transitional part has lower efficiency

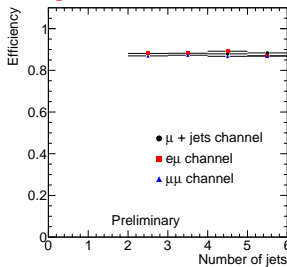
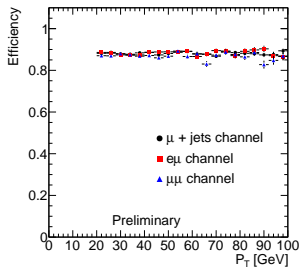


- On the ϕ plot ATLAS feet and 8 toroid coils are seen



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- In the function of p_T and nJet: flat \Rightarrow fine



Summary for trigger efficiency measurement

- Using $t\bar{t}$ dileptonic channels, we can measure trigger efficiency
- With 10 TeV 100 pb⁻¹ data, the estimated statistical error:

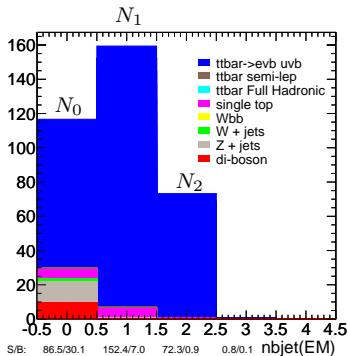
Method	$e\mu$	$ee / \mu\mu$
e10	0.3%	0.5%
mu10	2.0%	2.6%

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- Need a large statistics (fb⁻¹) to measure efficiencies as a function of η , ϕ , p_T and nJet



Part3. BTagging efficiency measurement: method



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Figure: Number of b tagged jets $t\bar{t} \rightarrow e\nu b \mu\nu b$

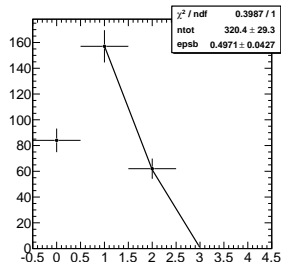
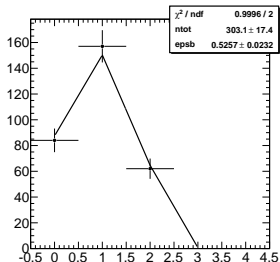
- Selection as trigger measurement
- $t\bar{t} \rightarrow$ other di-leptons ($\tau + \tau \dots$) are considered as signal
- The number of events with n btag jets N_i depends on ϵ_b , ϵ_{nonb} and F_{ij}
- We fit ϵ_b and N_{tot} , ϵ_{nonb} and F_{ij} fixed
 - ◊ The expected ϵ_b is 53.2%
 - ◊ Non-b jet mistag rate : ϵ_{nonb} 0.4%
 - ◊ F_{ij} is shown blow:

$i \setminus j$	0	1	2	3	4	5	6
0	-	-	$0.9 \pm 0.1\%$	$0.3 \pm 0.0\%$	$0.1 \pm 0.0\%$	$0.0 \pm 0.0\%$	$0.0 \pm 0.0\%$
1	-	$12.6 \pm 0.2\%$	$6.5 \pm 0.1\%$	$2.4 \pm 0.1\%$	$0.7 \pm 0.1\%$	$0.2 \pm 0.0\%$	-
2	$30.9 \pm 0.3\%$	$26.5 \pm 0.3\%$	$12.5 \pm 0.2\%$	$4.4 \pm 0.1\%$	$1.1 \pm 0.1\%$	-	-
3	$0.3 \pm 0.0\%$	$0.3 \pm 0.0\%$	$0.1 \pm 0.0\%$	$0.1 \pm 0.0\%$	-	-	-
4	$0.1 \pm 0.0\%$	$0.1 \pm 0.0\%$	$0.0 \pm 0.0\%$	-	-	-	-
5	$0.0 \pm 0.0\%$	$0.0 \pm 0.0\%$	-	-	-	-	-
6	$0.0 \pm 0.0\%$	-	-	-	-	-	-

Table: F_{ij} (fraction number of events with i jets matching b quark and j jets not)



Fitted results of total number of events



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N_t (without bkg)	Expected	fit N0 - N3	fit N1 - N3
$t\bar{t} \rightarrow e\nu b \mu\nu b$	317.6 ± 2.4	312.1 ± 14.5	307.9 ± 20.7
$t\bar{t} \rightarrow e\nu b e\nu b$	96.9 ± 1.3	98.9 ± 12.9	103.7 ± 18.7
$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	176.0 ± 1.8	172.8 ± 13.1	176.4 ± 25.5

N_t (with bkg)	Expected	fit N0 - N3	fit N1 - N3
$t\bar{t} \rightarrow e\nu b \mu\nu b$	317.6 ± 2.4	350.2 ± 14.3	322.2 ± 20.9
$t\bar{t} \rightarrow e\nu b e\nu b$	96.9 ± 1.3	115.8 ± 12.8	110.8 ± 19.2
$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	176.0 ± 1.8	205.4 ± 13.3	187.5 ± 26.0

Work in Progress !

Table: Results for total number of events with or without backgrounds



Fitted results of b tagging efficiency

ϵ_b (without bkg)	Expected	fit N0 - N3	fit N1 - N3
$t\bar{t} \rightarrow evb \mu\nu b$	$53.2 \pm 0.2\%$	$54.3 \pm 2.4\%$	$55.2 \pm 4.7\%$
$t\bar{t} \rightarrow evb evb$	$53.2 \pm 0.4\%$	$53.1 \pm 5.4\%$	$51.2 \pm 7.2\%$
$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	$53.4 \pm 0.3\%$	$54.1 \pm 3.8\%$	$53.8 \pm 7.3\%$

ϵ_b (with bkg)	Expected	fit N0 - N3	fit N1 - N3
$t\bar{t} \rightarrow evb \mu\nu b$	$53.2 \pm 0.2\%$	$49.8 \pm 2.2\%$	$54.3 \pm 4.6\%$
$t\bar{t} \rightarrow evb evb$	$53.2 \pm 0.4\%$	$47.3 \pm 4.6\%$	$50.1 \pm 7.1\%$
$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	$53.4 \pm 0.3\%$	$47.1 \pm 3.1\%$	$52.4 \pm 7.2\%$

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Table: Results for ϵ_b with or without backgrounds

- The ϵ_b is less affected by the background events than N_t
- N_0 makes ϵ_b lower because of its high background contamination



Systematics

- Relative statistical precision (10 TeV, 100 pb⁻¹) and systematics:

Fitting:	$N_0 - N_3$	$N_1 - N_3$
ϵ_{nonb} 0 - 2%:	+0.8% -1.6%	+0.8% -2.5%
background $\pm 100\%$:	9.6%	1.7%
b-jet label(ΔR 0.2 - 0.5):	+1.6% -2.5%	+1.6% -3.4%
jet energy scale $\pm 5\%$:	0.2%	0.2%
b-jet energy scale $\pm 1\%$:	< 0.1%	< 0.1%
AcerMC vs MC@NLO:	0.2%	0.1%
Total:	+9.8% -10.1%	+2.5% -4.2%
Statistical precision:	4.2%	6.8%

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- By fitting $N_0 - N_3$, if backgrounds are better known, systematic would be lower

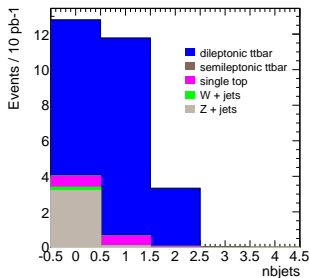


Part3.2 Measurement at 7 TeV, 10 pb⁻¹

Channels	Events	0-tag	1-tag	2-tags
$t\bar{t} \rightarrow evb \mu\nu b$	12.9±0.3	5	6	2
$t\bar{t} \rightarrow evb evb$	3.8±0.2	1.5	1.8	0.5
$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	6.6±0.2	2.3	3.3	1
Total	23.3±0.4	8.8	11.1	3.5

Work in Progress !

- With this statistics, we cannot separate the 3 channels ⇒ fit the sum of the N_{tag} histograms



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- No diboson background included yet, may be important

Channels	0-tag	1-tag	2-tags
signal	8.8	11.1	3.5
$t\bar{t} \rightarrow l\nu b \ q\bar{q} b$	0.07	0.04	0.01
single top	0.58	0.54	0.05
Z + jets	3.20	0.07	0.00
W + jets	0.18	0.00	0.00
Total Bkg	4.03	0.65	0.06
S/B	2.2	17	55

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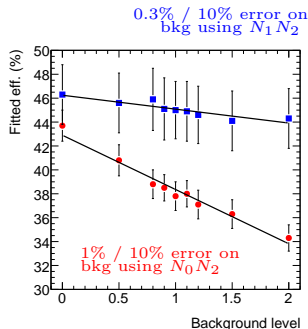


Results with backgrounds

	Expected	Without Background		With Background	
		$N_0 - N_2$	$N_1 - N_2$	$N_0 - N_2$	$N_1 - N_2$
ϵ_b	45.4%	$43.7 \pm 8.0\%$	$46.3 \pm 15.9\%$	$37.8 \pm 7.5\%$	$45.0 \pm 15.4\%$
N_{tot}	23.3	23.5 ± 5.0	24.0 ± 10.0	28.0 ± 5.6	25.5 ± 10.5

Work in Progress !

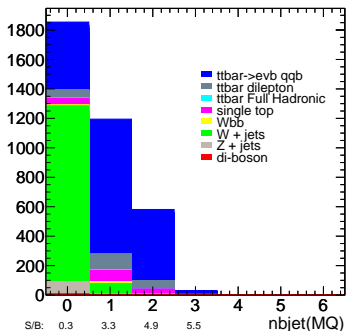
- Error bars = statistical error for 10 pb^{-1}
- Without background:
 - ▶ Average values in agreement with expected ones
 - ▶ Statistical error of factor 2 worse when using only $N_1 - N_2$ (expect lower sensitivity to bkg)
- Systematics due to background a factor 3 worse using $N_0 - N_2$



Work in Progress !



Part3.3 Measurement using semileptonic channels



Work in Progress !

Figure: Number of b tagged jets $t\bar{t} \rightarrow \mu\nu b qq b$

- Backgrounds greater than in dileptonic
- 10 TeV, 100 pb^{-1} sample
- Fit N_{tot} , ϵ_b and ϵ_c
- A limit is set on ϵ_c : [0%, 40%]
- The light jet mistagging rate is 0.166%

- ◇ S/B much smaller than in dileptonic
- ◇ Uncertainty: RMS for 100 pb^{-1}
- ◇ Fitted results, see below:

$t\bar{t} \rightarrow \mu\nu b \mu\nu b$	Expected	no bkg	with bkg
N_{tot}	1889.8 ± 5.8	1886.5 ± 48.7	2356.0 ± 57.7
ϵ_b (%)	54.4 ± 0.1	55.9 ± 4.7	52.6 ± 1.8
ϵ_c (%)	9.1 ± 0.1	8.2 ± 3.2	8.1 ± 2.7

Work in Progress !



Summary and to do list

- In order to measure $t\bar{t}$ cross section, we try to look with MC the trigger and b-tagging efficiency measurement
- We are eager to apply the measurement on data, but with 0.15 pb^{-1} data, $0.024 t\bar{t}$ is expected. So keep patient
- Finish the work on b-tagging efficiency measurement
- Get prepared for cross section measurement



